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•	BiCMOS Technology With Low Quiescent Power			CKAGE VIEW)	
•	Buffered Inputs	OE [1	\bigcup_{24}] v _{cc}
•	Noninverted Outputs	1D [2	23] 1Q
•	Input/Output Isolation From V _{CC}	2D [3	22	2Q
•	Controlled Output Edge Rates	3D [4		3Q
•	48-mA Output Sink Current		5	1	4Q
	•		6	1	5Q
	Output Voltage Swing Limited to 3.7 V	6D L	7	18	6Q
•	SCR Latch-Up-Resistant BiCMOS Process	7D [8	17	7Q
	and Circuit Design	8D [9	16	8Q
•	Packaged in Plastic Small-Outline Package	9D [10	15	9Q
		CLR	11	14	PRE
desc	ription	GND [12	13] LE

The CD74FCT843A is a 9-bit, bus-interface, D-type latch with 3-state outputs, designed

specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The device uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below V_{CC} . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes V_{CC} bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 mA.

The CD74FCT843A outputs are transparent to the inputs when the latch-enable (LE) input is high. The latches are transparent D-type latches. When LE goes low, the data is latched. The output-enable (\overline{OE}) input controls the 3-state outputs. When \overline{OE} is high, the outputs are in the high-impedance state. The latch operation is independent of the state of the output enable. This device, having preset (\overline{PRE}) and clear (\overline{CLR}) , are ideal for parity-bus interfacing. When \overline{PRE} is low, the outputs are high if \overline{OE} is low. \overline{PRE} overrides \overline{CLR} . When \overline{CLR} is low, the outputs are low if \overline{OE} is low. When \overline{CLR} is high, data can be entered into the latch. The device provides noninverted outputs.

OE does not affect the internal operations of the latch. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

The CD74FCT843A is characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each latch)

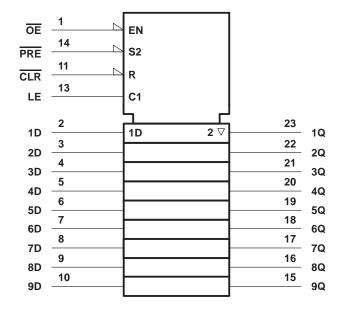
	OUTPUT				
PRE	CLR	OE	LE	D	Q
L	Х	L	Х	Χ	Н
Н	L	L	X	Χ	L
Н	Н	L	Н	L	L
Н	Н	L	Н	Н	Н
Н	Н	L	L	Χ	Q ₀
Χ	X	Н	X	Χ	Z



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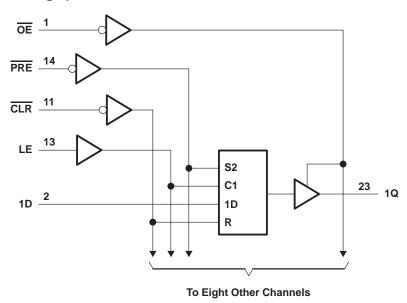


logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

DC supply voltage range, V _{CC}	0.5 V to 6 V
DC input clamp current, I_{IK} ($V_I < -0.5 \text{ V}$)	–20 mA
DC output clamp current, I _{OK} (V _O < -0.5 V)	
DC output sink current per output pin, I _{OL}	70 mA
DC output source current per output pin, I _{OH}	–30 mA
Continuous current through V _{CC} , (I _{CC})	237 mA
Continuous current through GND	
Package thermal impedance, θ _{JA} (see Note 1)	46°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 2)

		MIN	MAX	UNIT
Vcc	Supply voltage	4.75	5.25	V
VIH	High-level input voltage	2		V
V _{IL}	Low-level input voltage		0.8	V
٧ı	Input voltage	0	VCC	V
٧o	Output voltage	0	VCC	V
IOH	High-level output current		-15	mA
loL	Low-level output current		48	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	CONDITIONS				UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN MAX	MIN	MAX	UNIT
VIK	$I_{I} = -18 \text{ mA}$	4.75 V	-1.2	2	-1.2	V
VOH	$I_{OH} = -15 \text{ mA}$	4.75 V	2.4	2.4		V
V _{OL}	$I_{OL} = 48 \text{ mA}$	4.75 V	0.5	5	0.55	V
lį	$V_I = V_{CC}$ or GND	5.25 V	±0.′		±1	μΑ
loz	$V_O = V_{CC}$ or GND	5.25 V	±0.5	5	±10	μΑ
los [‡]	$V_I = V_{CC}$ or GND, $V_O = 0$	5.25 V	-75	-75		mA
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.25 V	8	3	80	μΑ
ΔlCC§	One input at 3.4 V, Other inputs at V _{CC} or GND	5.25 V	1.6	5	1.6	mA
Ci	$V_I = V_{CC}$ or GND		10		10	pF
Co	$V_O = V_{CC}$ or GND		15	5	15	pF

[‡] Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.



NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

[§] This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or VCC.

CD74FCT843A BiCMOS 9-BIT BUS-INTERFACE D-TYPE LATCH WITH 3-STATE OUTPUTS

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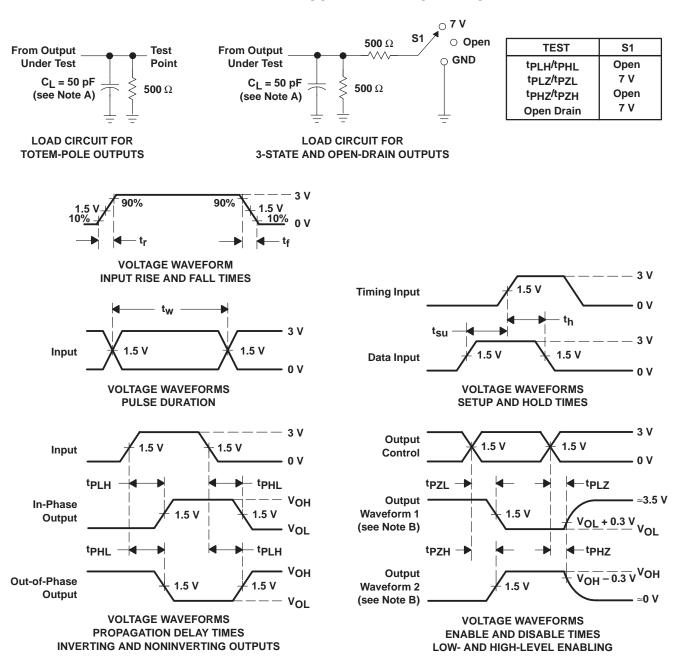
timing requirements over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

			MIN	MAX	UNIT
		CLR low	8		
t _W	Pulse duration	PRE low	8		ns
		LE low	4		
		Data before LE↓	2.5		
t _{su}	Setup time	PRE inactive	1.4		ns
		CLR inactive	1.4		
t _h	Hold time	Data before LE↓	2.5		ns
t _{rec}	Recovery time	PRE, CLR	14		ns

switching characteristics over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T _A = 25°C	MIN	MAX	UNIT
	D	, ,	6.8	1.5	9	
^t pd	LE	Q	9	1.5	12	ns
^t PLH	PRE	Q	9	1.5	12	ns
^t PHL	CLR	Q	9.8	1.5	13	ns
t _{en}	ŌĒ	Q	10.5	1.5	14	ns
t _{dis}	ŌĒ	Q	6	1.5	8	ns

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, t_f and $t_f = 2.5$ ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpHL and tpLH are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms







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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD74FCT843AM	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74FCT843AM96	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74FCT843AM96E4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74FCT843AM96G4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74FCT843AME4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74FCT843AMG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

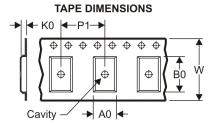
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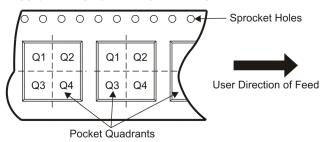
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74FCT843AM96	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1



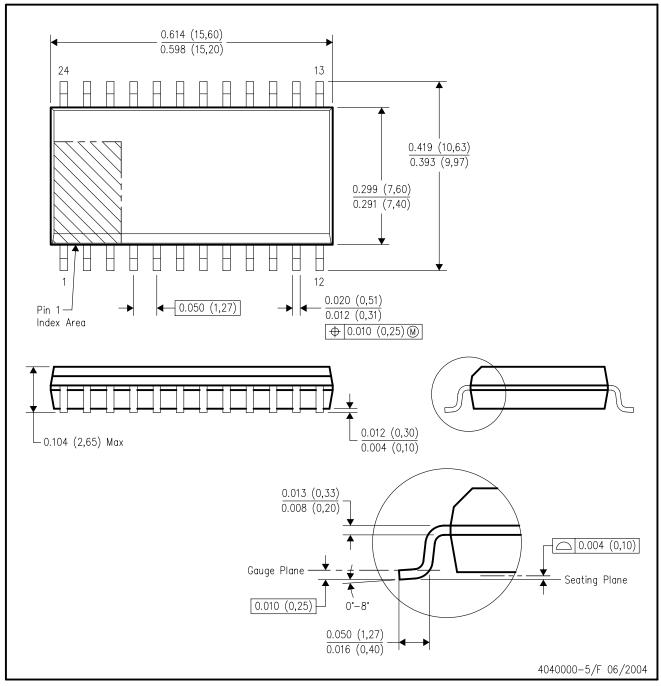


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74FCT843AM96	SOIC	DW	24	2000	346.0	346.0	41.0

DW (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



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